

<b>Notice of References Cited</b>	Application/Control No. 10/772,745		Applicant(s)/Patent Under Reexamination KRISHNAN ET AL.	
	Examiner Frank I. Choi		Art Unit 1616	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,495,177	12-2002	deVries et al.	426/72
*	B	US-6,368,625	04-2002	Siebert et al.	424/466
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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